## Application/Control No. Applicant(s)/Patent Under Reexamination 10/606,048 SHIN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2814 Howard Weiss **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2002/0041030 04-2002 Kim et al. 257/758 Α US-6,048,792 04-2000 Watanabe et al. 438/656 В US-6,028,362 02-2000 Omura 257/774 С US-D US-Ε US-F US-G US-US-US-J US-Κ US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Name Classification Country Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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